

13 μ A/ch, Rail-to-Rail Output Dual CMOS Operational Amplifier

■ GENERAL DESCRIPTION

The NJU7027 is a Rail-to-Rail output single supply dual CMOS operational amplifier with a low operating current of 13 μ A per channel and high RF noise immunity. It offers a single supply voltage operation from +1.8V to +5.5V, rail-to-rail output swing in the rails and input voltage range from ground. Further the NJU7027 has a low bias current of 1pA, which makes it well-suited for a low side current sense amplifier combining with input voltage range from ground. The combination of low voltage operation, low operating current and rail-to-rail output swing makes it well-suited for a wide variety of battery powered applications. The NJU7027 is available in a small surface mount package of MSOP8 (TVSP8) and an ultra small lead-less package of ESON8.

■ PACKAGE OUTLINE



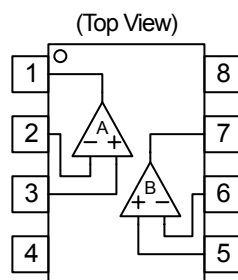
■ FEATURES

- Low Operating Current 13 μ A/ch typ. (at V_{DD} = 5V), 12 μ A/ch typ. (at V_{DD} = 3V)
11 μ A/ch typ. (at V_{DD} = 1.8V)
- Low Operating Voltage V_{opr} = 1.8V to 5.5V
- Rail-to-Rail Output V_{OH} =4.9V min./ V_{OL} =0.1V max. (at V_{DD} = 5V, R_L =100k Ω)
 V_{OH} =4.8V min./ V_{OL} =0.2V max. (at V_{DD} = 5V, I_O =1mA)
- Package MSOP8 (TVSP8) MEET JEDEC MO-187-DA/ THIN TYPE ,
ESON8(2.0mm x 2.0mm)
- RF Noise Immunity reducing troubles caused by RF noise from mobile phones
- CMOS Process

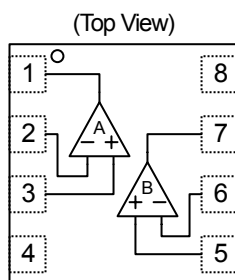
■ APPLICATION

- Battery-operated application
- Battery monitor
- Current sensor
- Photodiode amplification

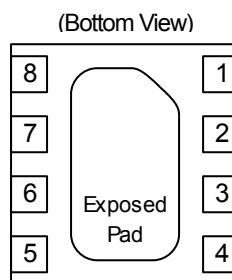
■ PIN CONFIGURATION



NJU7027RB1



NJU7027KU1



About Exposed Pad

Connect the Exposed Pad on the GND.

PIN FUNCTION

1. A OUTPUT
2. A -INPUT
3. A +INPUT
4. V_{SS}
5. B +INPUT
6. B -INPUT
7. B OUTPUT
8. V_{DD}

■ ABSOLUTE MAXIMUM RATINGS (Ta=25°C, unless otherwise noted.)

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	V _{DD}	+7	V
Input Common Mode Voltage	V _{ICM}	V _{SS} -0.3 to V _{DD} +0.3	V
Differential Input Voltage	V _{ID}	±7 (Note1)	V
Power Dissipation	P _D	(MSOP8 (TVSP8))410 (Note2) (ESON8) 360 (Note2) (ESON8) 940 (Note3)	mW
Operating Temperature Range	T _{opr}	-40 to +85	°C
Storage Temperature Range	T _{stg}	-55 to +125	°C

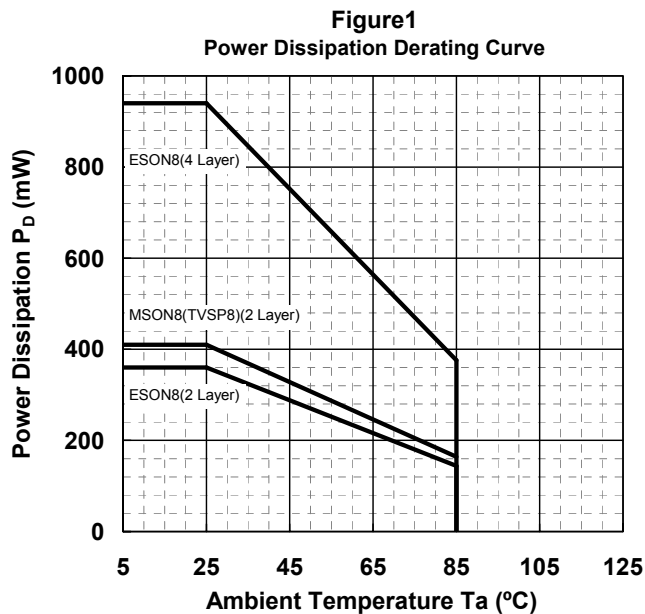
(Note1) For supply voltage less than +7V, the absolute maximum rating is equal to the supply voltage.

(Note2) EIA/JEDEC STANDARD Test board (76.2 x 114.3 x 1.6mm, 2 layers, FR-4) mounting.

(Note3) EIA/JEDEC STANDARD Test board (76.2 x 114.3 x 1.6mm, 4 layers, FR-4) mounting.

(Note4) Do not exceed "Power dissipation: P_D" in which power dissipation in IC is shown by the absolute maximum rating.

See Figure "Power Dissipation Curve" when ambient temperature is over 25°C.



Pkg.	ΔPd (mW/°C)	Pd (25°C)	Pd (85°C)
MSOP8(TVSP8)(2 Layer)	-4.10	410	164
ESON8(2 Layer)	-3.60	360	144
ESON8(4 Layer)	-9.40	940	376

■ RECOMMENDED OPERATING CONDITION(Ta=25°C)

PARAMETER	SYMBOL	RATING	UNIT
Supply Voltage	V _{DD}	1.8 to 5.5	V

■ ELECTRICAL CHARACTERISTICS

DC CHARACTER ($V_{DD}=5V$, $V_{SS}=0V$, $T_a=25^{\circ}C$, unless otherwise noted.)

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Supply Current	I_{DD}	No Signal	-	26	40	μA
Input Offset Voltage	V_{IO}	$V_{ic}=0V$, $R_S=50\Omega$	-	0.9	4	mV
Input Offset Voltage drift	$\Delta V_{IO}/\Delta T$		-	1.5	-	$\mu V/^{\circ}C$
Input Bias Current	I_B		-	1	-	pA
Input Offset Current	I_{IO}		-	1	-	pA
Open loop gain	A_V	$V_o=0.5V$ to $4.5V$, $R_L=100k\Omega$ to $2.5V$	70	90	-	dB
Common Mode Rejection Ratio	CMR	$V_{ICM}=0V$ to $4.1V$	65	80	-	dB
Supply Voltage Rejection Ratio	SVR	$V_{DD}=1.8V$ to $5.5V$	70	90	-	dB
Maximum Output Voltage 1	V_{OH1}	$R_L=100k\Omega$ to $2.5V$	4.9	4.95	-	V
	V_{OL1}	$R_L=100k\Omega$ to $2.5V$	-	0.05	0.1	V
Maximum Output Voltage 2	V_{OH2}	$R_L=100k\Omega$ to $0V$	4.9	4.95	-	V
	V_{OL2}	$R_L=100k\Omega$ to $0V$	-	0.02	0.05	V
Maximum Output Voltage 3	V_{OH3}	$I_{source}=1mA$	4.8	4.85	-	V
	V_{OL3}	$I_{sink}=1mA$	-	0.15	0.2	V
Common Mode Input Voltage Range	V_{ICM}	CMR $\geq 65dB$	0	-	4.1	V

AC CHARACTER ($V_{DD}=5V$, $V_{SS}=0V$, $T_a=25^{\circ}C$, unless otherwise noted.)

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gain Bandwidth Product	GBW	$R_L=100k\Omega$ to $2.5V$, $C_L=20pF$, $f=10kHz$	-	160	-	kHz
Phase Margin	ϕ_M	$R_L=100k\Omega$ to $2.5V$, $C_L=20pF$	-	80	-	deg
Gain Margin	G_M	$R_L=100k\Omega$ to $2.5V$, $C_L=20pF$	-	15	-	dB
Equivalent Input Noise Voltage	e_n	$f=1kHz$	-	50	-	$nV/\sqrt{Hz}$
Channel Separation	CS	$f=1kHz$	-	120	-	dB
Slew Rate	SR	$G_V=0dB$, $R_L=100k\Omega$ to $2.5V$, $C_L=20pF$, $V_{in}=3V_{pp}$ (1V to 4V) (Note5), (Note6)	-	0.05	-	V/us
Power Bandwidth	PBW	$G_V=6dB$, $R_F=50k\Omega$, $R_G=50k\Omega$, $C_L=20pF$, $V_{in}=2.5V_{pp}$ (1.25V to 3.75V), $V_o\geq 4.8V_{pp}$ (Note7)	-	5	-	kHz
Total Harmonic Distortion	THD	$G_V=6dB$, $R_F=50k\Omega$, $R_G=50k\Omega$, $C_L=20pF$, $V_o=4V_{pp}$, $f=100Hz$ (Note7)	-	0.01	-	%

(Note5) Slew rate is defined by the lower value of the rise or fall.

(Note6) See figure2-1 for test circuit.

(Note7) See figure2-3 for test circuit.

■ ELECTRICAL CHARACTERISTICS

DC CHARACTER ($V_{DD}=3V$, $V_{SS}=0V$, $T_a=25^{\circ}C$, unless otherwise noted.)

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Supply Current	I_{DD}	No Signal	-	24	36	μA
Input Offset Voltage	V_{IO}	$V_{ICM}=0V$, $R_S=50\Omega$	-	0.9	4	mV
Input Offset Voltage drift	$\Delta V_{IO}/\Delta T$		-	1.5	-	$\mu V/^{\circ}C$
Input Bias Current	I_B		-	1	-	pA
Input Offset Current	I_{IO}		-	1	-	pA
Open loop gain	A_V	$V_O=0.5V$ to $2.5V$, $R_L=100k\Omega$ to $1.5V$	70	90	-	dB
Common Mode Rejection Ratio	CMR	$V_{ICM}=0V$ to $2.1V$	65	80	-	dB
Supply Voltage Rejection Ratio	SVR	$V_{DD}=1.8V$ to $5.5V$	70	90	-	dB
Maximum Output Voltage 1	V_{OH1}	$R_L=100k\Omega$ to $1.5V$	2.9	2.95	-	V
	V_{OL1}	$R_L=100k\Omega$ to $1.5V$	-	0.05	0.1	V
Maximum Output Voltage 2	V_{OH2}	$R_L=100k\Omega$ to $0V$	2.9	2.95	-	V
	V_{OL2}	$R_L=100k\Omega$ to $0V$	-	0.02	0.05	V
Maximum Output Voltage 3	V_{OH3}	$I_{source}=1mA$	2.8	2.85	-	V
	V_{OL3}	$I_{sink}=1mA$	-	0.15	0.2	V
Common Mode Input Voltage Range	V_{ICM}	CMR $\geq 65dB$	0	-	2.1	V

AC CHARACTER ($V_{DD}=3V$, $V_{SS}=0V$, $T_a=25^{\circ}C$, unless otherwise noted.)

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gain Bandwidth Product	GBW	$R_L=100k\Omega$ to $1.5V$, $C_L=20pF$, $f=10kHz$	-	150	-	kHz
Phase Margin	ϕ_M	$R_L=100k\Omega$ to $1.5V$, $C_L=20pF$	-	80	-	deg
Gain Margin	G_M	$R_L=100k\Omega$ to $1.5V$, $C_L=20pF$	-	15	-	dB
Equivalent Input Noise Voltage	e_n	$f=1kHz$	-	50	-	$nV/\sqrt{Hz}$
Channel Separation	CS	$f=1kHz$	-	115	-	dB
Slew Rate	SR	$G_V=0dB$, $R_L=100k\Omega$ to $1.5V$, $C_L=20pF$, $V_{in}=1V_{pp}$ (1V to 2V) (Note5), (Note6)	-	0.05	-	V/us
Power Bandwidth	PBW	$G_V=6dB$, $R_F=50k\Omega$, $R_G=50k\Omega$, $C_L=20pF$, $V_{in}=1.5V_{pp}$ (0.75V to 2.25V), $V_O\geq 2.8V_{pp}$ (Note7)	-	8	-	kHz
Total Harmonic Distortion	THD	$G_V=6dB$, $R_F=50k\Omega$, $R_G=50k\Omega$, $C_L=20pF$, $V_O=2V_{pp}$, $f=100Hz$ (Note7)	-	0.01	-	%

(Note5) Slew rate is defined by the lower value of the rise or fall.

(Note6) See figure2-1 for test circuit.

(Note7) See figure2-3 for test circuit.

■ ELECTRICAL CHARACTERISTICS

DC CHARACTER ($V_{DD}=1.8V$, $V_{SS}=0V$, $T_a=25^{\circ}C$, unless otherwise noted.)

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Supply Current	I_{DD}	No Signal	-	22	34	μA
Input Offset Voltage	V_{IO}	$V_{ic}=0V$, $R_S=50\Omega$	-	0.9	4	mV
Input Offset Voltage drift	$\Delta V_{IO}/\Delta T$		-	1.5	-	$\mu V/^{\circ}C$
Input Bias Current	I_B		-	1	-	pA
Input Offset Current	I_{IO}		-	1	-	pA
Open loop gain	A_V	$V_o=0.5V$ to $2.5V$, $R_L=100k\Omega$ to $0.9V$	70	90	-	dB
Common Mode Rejection Ratio	CMR	$V_{ICM}=0V$ to $0.9V$	65	80	-	dB
Supply Voltage Rejection Ratio	SVR	$V_{DD}=1.8V$ to $5.5V$	70	90	-	dB
Maximum Output Voltage 1	V_{OH1}	$R_L=100k\Omega$ to $0.9V$	1.7	1.75	-	V
	V_{OL1}	$R_L=100k\Omega$ to $0.9V$	-	0.05	0.1	V
Maximum Output Voltage 2	V_{OH2}	$R_L=100k\Omega$ to $0V$	1.7	1.75	-	V
	V_{OL2}	$R_L=100k\Omega$ to $0V$	-	0.02	0.05	V
Maximum Output Voltage 3	V_{OH3}	$I_{source}=0.5mA$	1.5	1.55	-	V
	V_{OL3}	$I_{sink}=0.5mA$	-	0.25	0.3	V
Common Mode Input Voltage Range	V_{ICM}	CMR $\geq 65dB$	0	-	0.9	V

AC CHARACTER ($V_{DD}=1.8V$, $V_{SS}=0V$, $T_a=25^{\circ}C$, unless otherwise noted.)

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gain Bandwidth Product	GBW	$R_L=100k\Omega$ to $0.9V$, $C_L=20pF$, $f=10kHz$	-	140	-	kHz
Phase Margin	ϕ_M	$R_L=100k\Omega$ to $0.9V$, $C_L=20pF$	-	80	-	deg
Gain Margin	G_M	$R_L=100k\Omega$ to $0.9V$, $C_L=20pF$	-	15	-	dB
Equivalent Input Noise Voltage	e_n	$f=1kHz$	-	50	-	$nV/\sqrt{Hz}$
Channel Separation	CS	$f=1kHz$	-	110	-	dB
Slew Rate	SR	$G_V=0dB$, $R_L=100k\Omega$ to $1.5V$, $C_L=20pF$, $V_{in}=0.5V_{pp}$ ($0.3V$ to $0.8V$) (Note5), (Note8)	-	0.05	-	V/ μs
Power Bandwidth	PBW	$G_V=6dB$, $R_F=50k\Omega$, $R_G=50k\Omega$, $C_L=20pF$, $V_{in}=0.9V_{pp}$ ($0V$ to $0.9V$), $V_o\geq 1.6V_{pp}$ (Note9)	-	14	-	kHz
Total Harmonic Distortion	THD	$G_V=6dB$, $R_F=50k\Omega$, $R_G=50k\Omega$, $C_L=20pF$, $V_o=1V_{pp}$, $f=100Hz$ (Note9)	-	0.01	-	%

(Note5) Slew rate is defined by the lower value of the rise or fall.

(Note8) See figure2-2 for test circuit.

(Note9) See figure2-4 for test circuit.

■ MEASUREMENT CIRCUITS

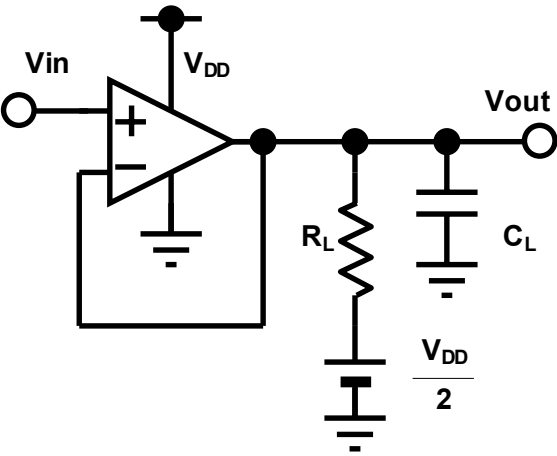


Figure 2-1:Measurement circuit 1

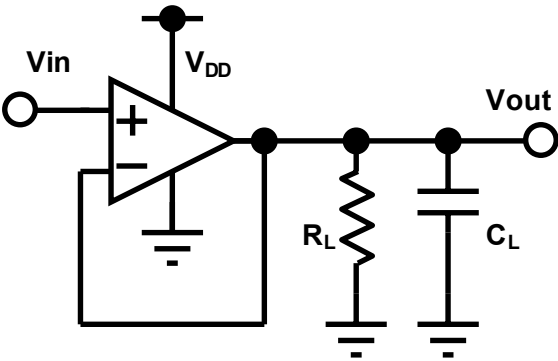


Figure 2-2:Measurement circuit 2

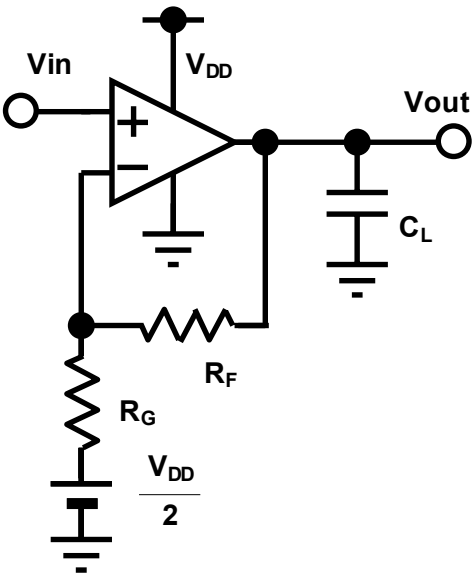


Figure 2-3:Measurement circuit 3

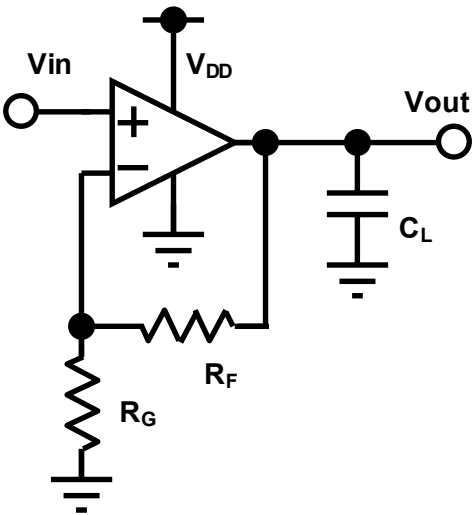
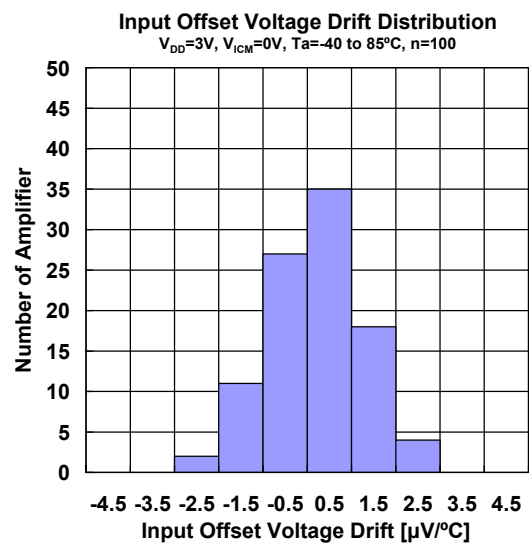
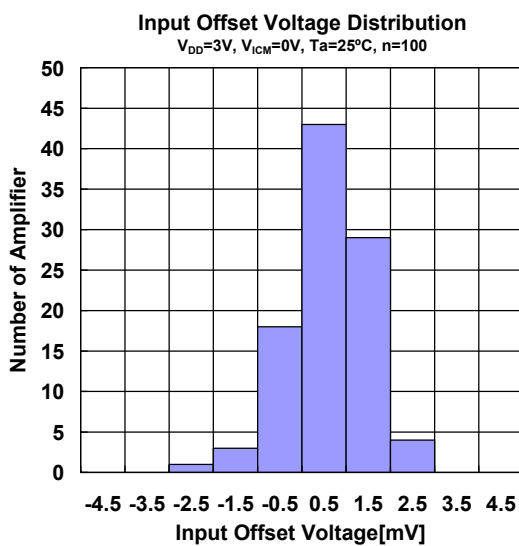
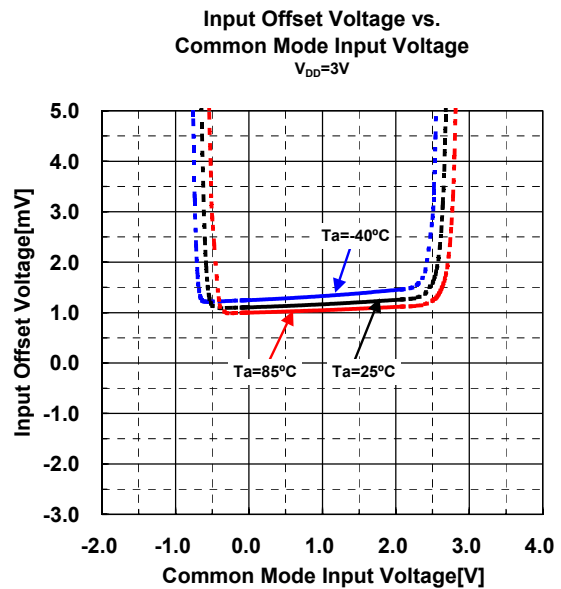
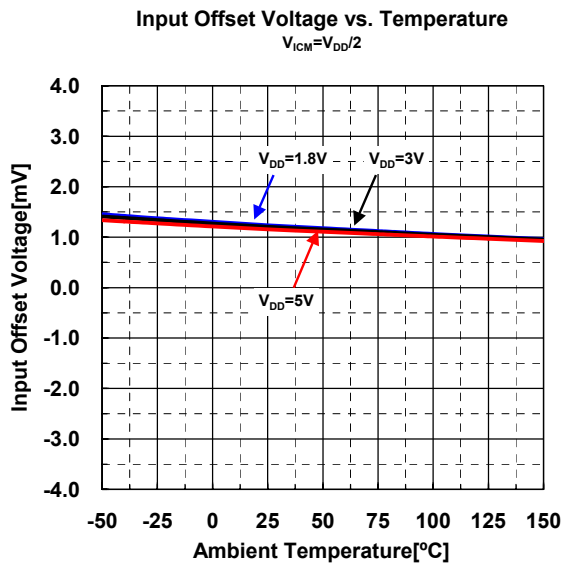
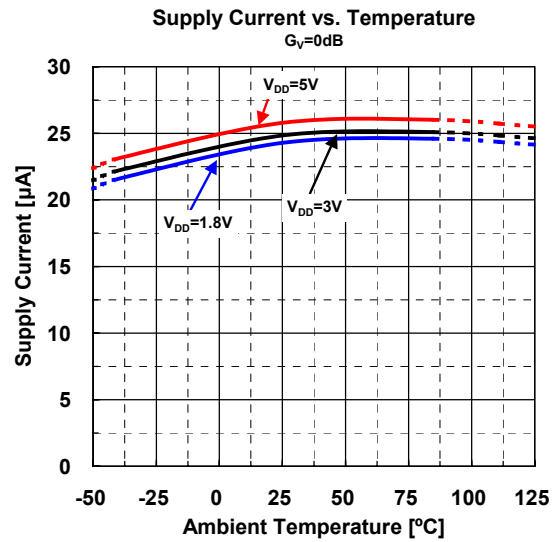
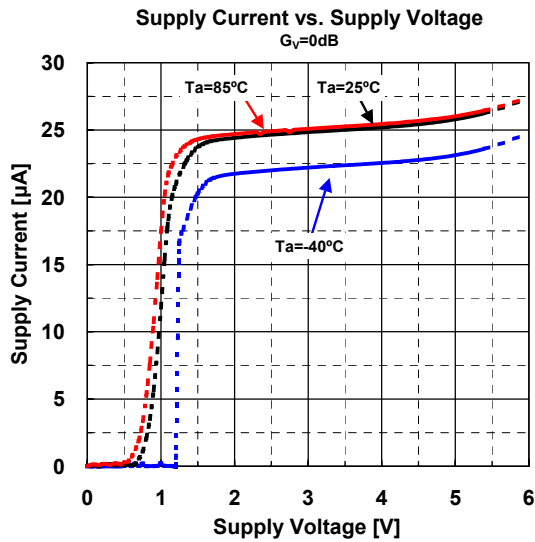
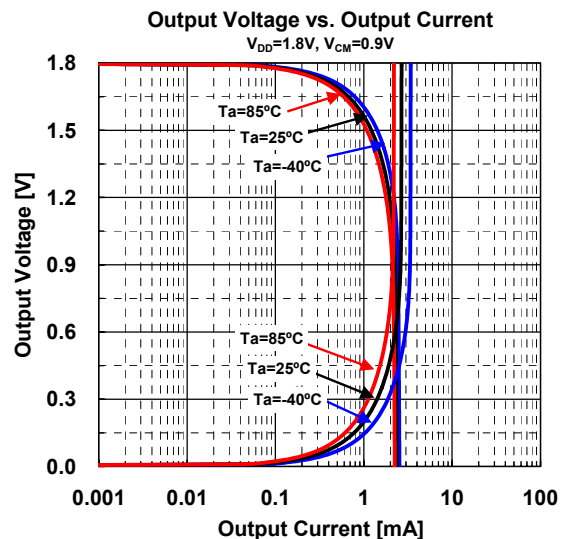
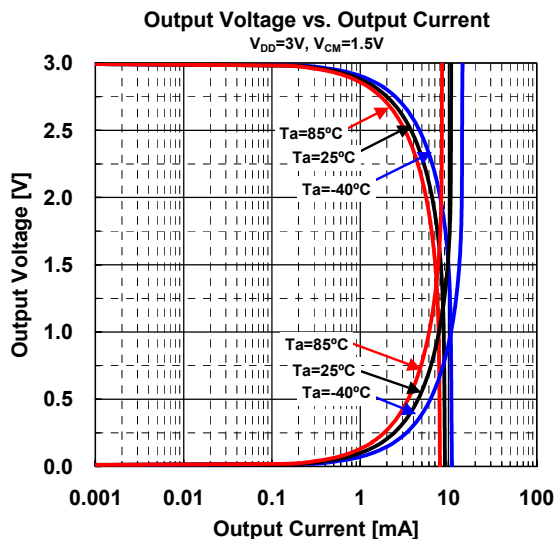
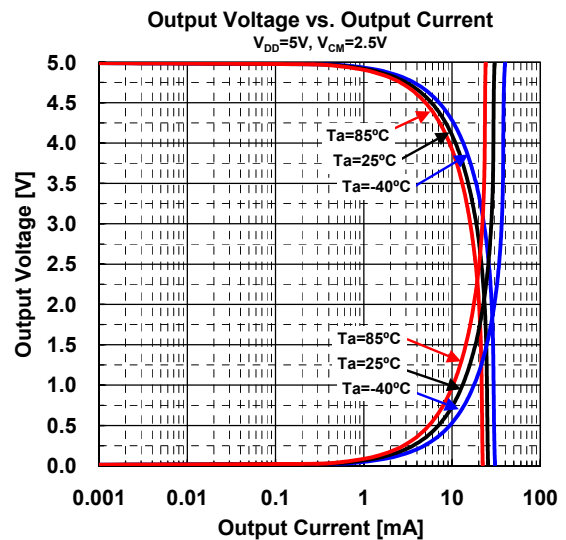
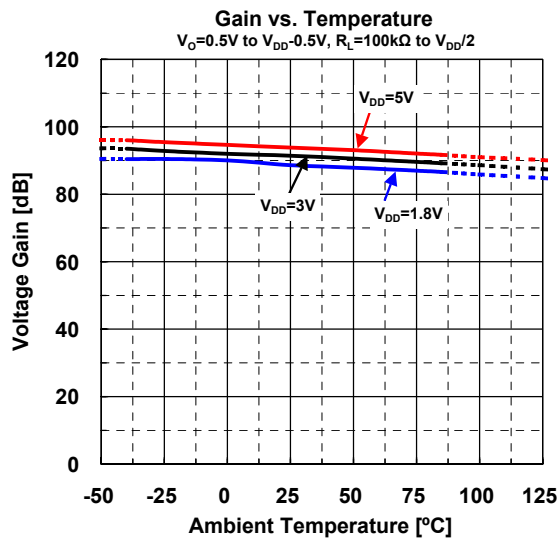
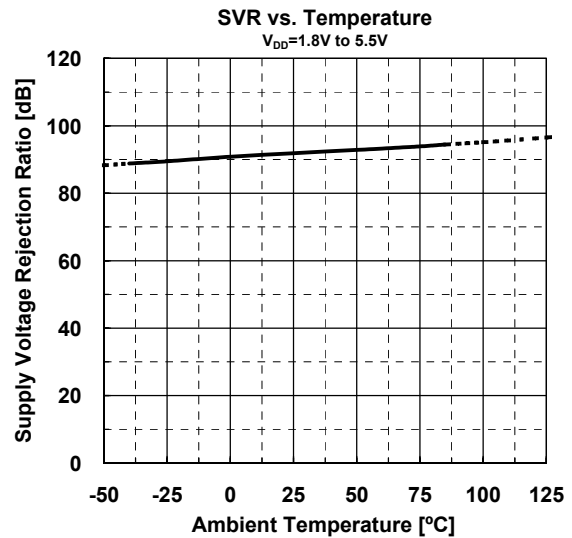
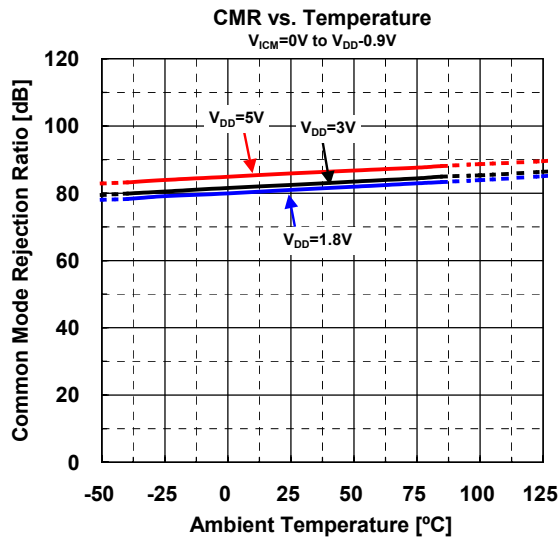


Figure 2-4:Measurement circuit 4

■ TYPICAL CHARACTERISTICS

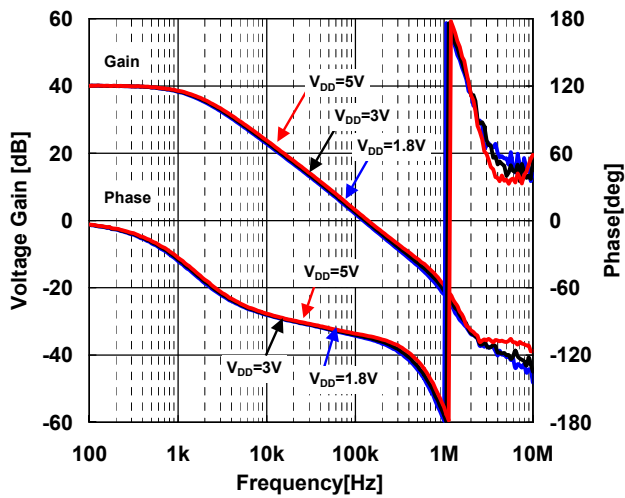


■ TYPICAL CHARACTERISTICS

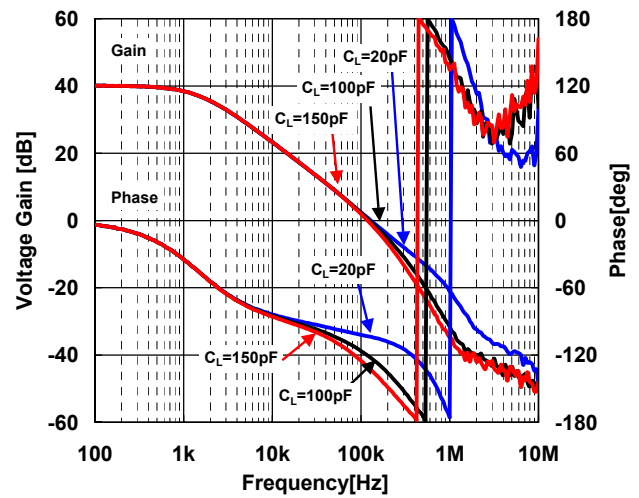


■ TYPICAL CHARACTERISTICS

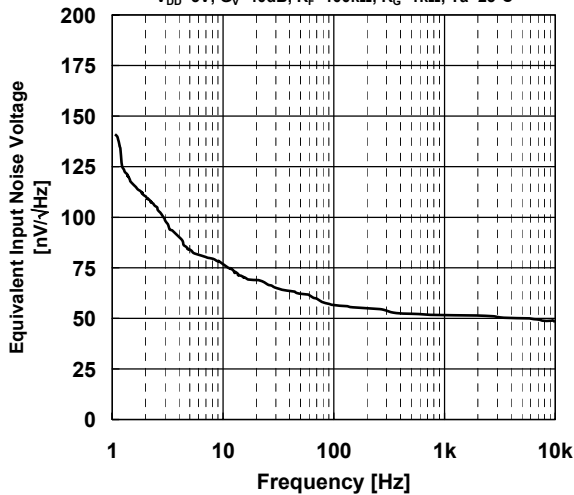
Gain/Phase vs. Frequency
 $R_F=1M\Omega$, $R_G=1K\Omega$, $R_L=100K\Omega$, $C_L=20pF$, $T_a=25^\circ C$



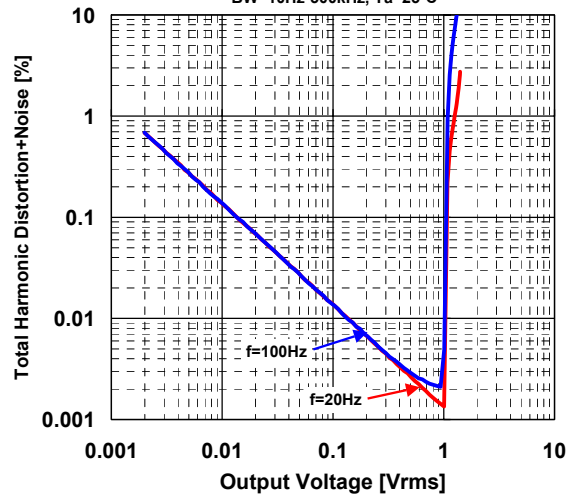
Gain/Phase vs. Frequency
 $V_{DD}=3V$, $R_F=1M\Omega$, $R_G=1K\Omega$, $R_L=100K\Omega$, $T_a=25^\circ C$



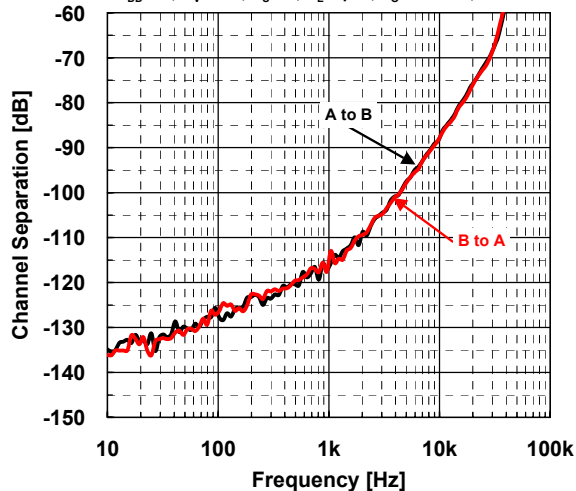
Voltage Noise vs. Frequency
 $V_{DD}=3V$, $G_V=40dB$, $R_F=100K\Omega$, $R_G=1K\Omega$, $T_a=25^\circ C$



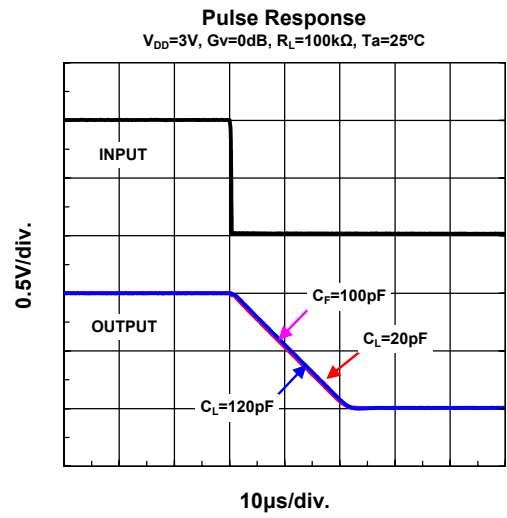
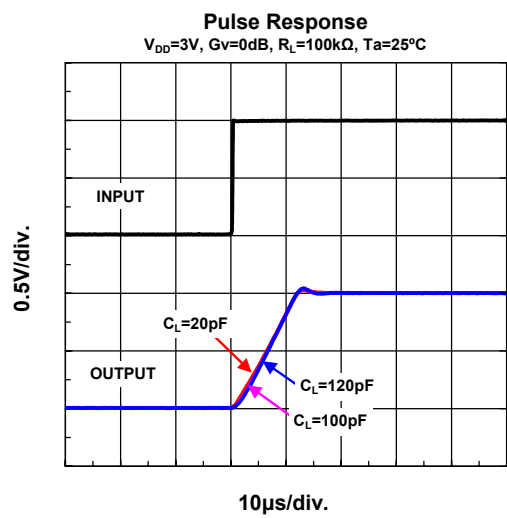
THD+Noise vs. Output Voltage
 $V_{DD}=3V$, $G_V=6dB$, $R_F=50K\Omega$, $C_L=20pF$
 $BW=10Hz-500kHz$, $T_a=25^\circ C$



Channel Separation vs. Frequency
 $V_{DD}=3V$, $G_V=-100$, $R_S=1K$, $R_L=open$, $V_O=0.5Vrms$, $T_a=25^\circ C$



■ TYPICAL CHARACTERISTICS



[CAUTION]
The specifications on this databook are only given for information, without any guarantee as regards either mistakes or omissions. The application circuits in this databook are described only to show representative usages of the product and not intended for the guarantee or permission of any right including the industrial rights.